## Applicant(s)/Patent Under Application/Control No. Reexamination ZHANG ET AL. 08/811,742 Notice of References Cited Examiner Art Unit Page 1 of 1 Khiem D Nguyen 2823 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY Α US-US-В C US-US-D US-Ε F US-US-G US-Н US-1 US-US-Κ L US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	S. Caune et al. "Combined CW-laser and furnace annealing of amorphous Si and Ge in contact with some metals" Applied Surface Science 36 (1989) pages 597-604.
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"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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